_	 HI INC	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,056	ANDO, TAKESHI	
Examiner	Art Unit	
Chuck Huynh	2617	

	SEAR	CHED	
Class	Subclass	Date	Examiner
Update	Search	11/19/2007	
455	. 432.1	11/19/2007	
	4		
		, , , , , , , , , , , , , , , , , , , ,	
		,	
]		

INT	ERFERENC	E SEARCH	HED	
Class	Subclass	Date	Examiner	
	,			

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Class/Subclass	11/20/2007	
Combine Text Search	11/19/2007	
· · ·		